

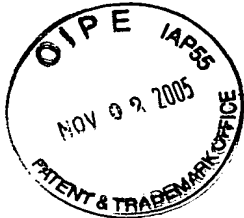
J&R-0694

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CERTIFICATION OF MAILING OR TRANSMISSION

I hereby certify that this correspondence is being deposited with the United States Postal Service with sufficient postage as first class mail in an envelope addressed to the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 or facsimile transmitted to the U.S. Patent and Trademark Office on the date shown below.



*Thomas Zettler*  
Signature

*October 31, 2005*  
Date

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applic. No. : 09/922,479 Confirmation No. 7212  
Applicant : Thomas Zettler  
Filed : August 3, 2001  
Title : Method and Device for Testing an Integrated  
Circuit, Integrated Circuit to be Tested, and  
Wafer with a Large Number of Integrated  
Circuits to be Tested  
Group Art Unit : 2133  
Examiner : Phung M. Chung  
Docket No. : J&R-0694  
Customer No. : 24131

A M E N D M E N T

**Mail Stop Amendment**

Hon. Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

S i r :

Responsive to the Office Action dated August 30, 2005, kindly  
amend the above-identified application as follows:

**Amendments to the Claims begin on page 2 of this paper.**

**Remarks/Arguments begin on page 12 of this paper.**

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